

# Search History

L Number	Hits	Search Text	DB	Time stamp
1	261524	interconnect	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/02 15:07
2	17266	conductive near line\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/02 15:07
3	637904	capacitor or capacitive	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/02 15:08
4	93895	bias near2 voltage	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/02 15:08
5	237141	function\$3 near2 (device or circuit)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/02 15:09
6	4752	interconnect and (conductive near line\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/02 15:09
7	1758	(interconnect and (conductive near line\$1)) and (capacitor or capacitive)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/02 15:09
8	160	((interconnect and (conductive near line\$1)) and (capacitor or capacitive)) and (bias near2 voltage)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/02 15:09
9	51	((interconnect and (conductive near line\$1)) and (capacitor or capacitive)) and (bias near2 voltage)) and (function\$3 near2 (device or circuit))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/09/02 15:09